TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

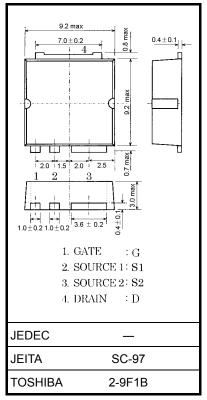
2SK3440

Switching Regulator, DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance: $RDS(ON) = 6.5 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 30 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 60 \ V)$
- Enhancement mode: V_{th} = 2.0 to 4.0 V (V_{DS} = 10 V, I_D = 1 mA)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	60	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	60	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	۱ _D	50	А	
	Pulse (Note 1)	I _{DP}	200	A	
Drain power dissipation (Tc = 25° C)		PD	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	644	mJ	
Avalanche current		I _{AR}	50	А	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	



Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W	

Notice: Please use the S1 pin for gate input signal return. Make sure that the

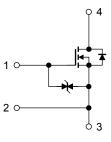
main current flows into the S2 pin.

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 50 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 350 μH , R_G = 25 Ω , I_{AR} = 50 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

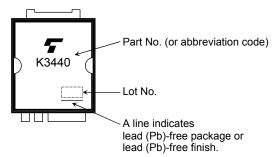
This transistor is an electrostatic-sensitive device. Please handle with caution.



Unit: mm

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Marking



Electrical Characteristics (Note 4) (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 25~V,~V_{DS}=0~V$			±10	μA
Drain cut-off current		I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$		—	100	μA
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60	—		V
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0		4.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}$	_	6.5	8	mΩ
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}$	15	30	_	S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		3700	_	pF
Reverse transfer capacitance		C _{rss}		_	280	_	pF
Output capacitance		C _{oss}		_	1320	_	pF
Switching time	Rise time	tr	$V_{GS} \stackrel{10}{}_{0} \vee \int I_{D} = 25 \text{ A}$		12	_	
	Turn-on time	t _{on}			30		
	Fall time	t _f			12		ns
	Turn-off time	t _{off}	V _{IN} : Duty ≦ 1%, t _w = 10 μs	_	50		
Total gate charge (gate-source plus gate-drain)		Qg			55	_	nC
Gate-source charge		Q _{gs}	$V_{DD} \simeq 48 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 50 \text{ A}$	_	35	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	20		nC

Note 4: Connect the S1 and S2 pins together, and ground them except during switchin time measurement.

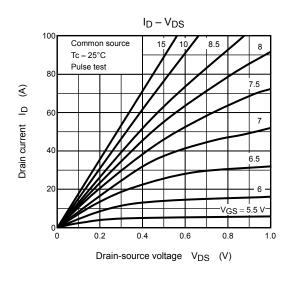
Source-Drain Ratings and Characteristics (Note 5) (Ta = 25°C)

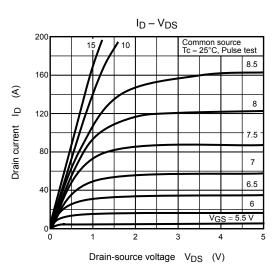
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	—	_	_	50	А
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	—	_	_	200	А
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	—			1	A
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	—			4	A
Forward voltage (diode)	V _{DS2F}	$I_{DR} = 50 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 50 \text{ A}, V_{GS} = 0 \text{ V},$	_	70	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs		123	_	nC

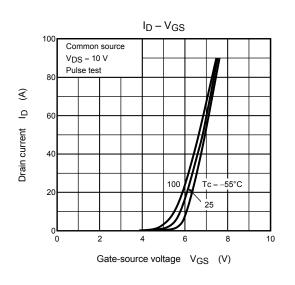
Note 5: I_{DR}1, I_{DRP}1: Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. I_{DR}2, I_{DRP}2: Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

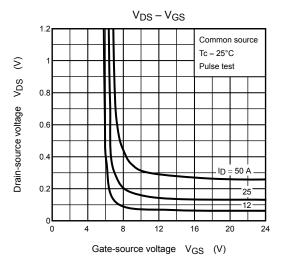
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

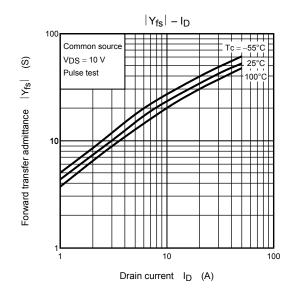
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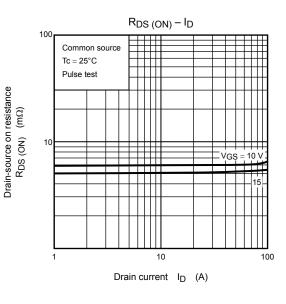




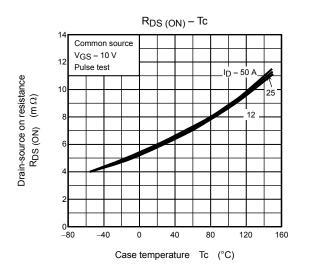


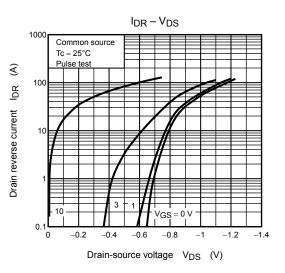


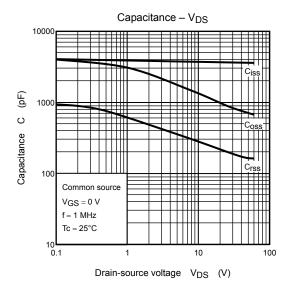




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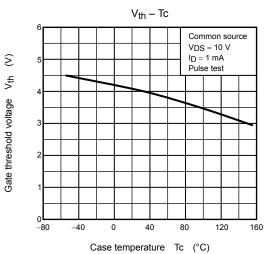


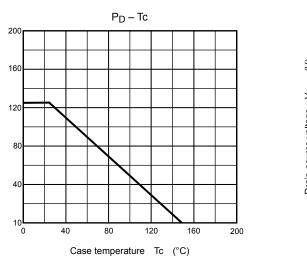


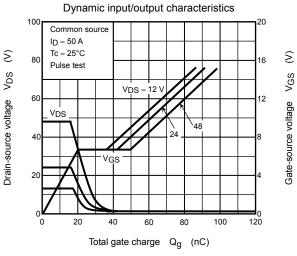


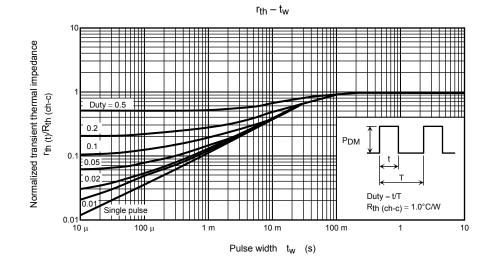
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Drain power dissipation PD

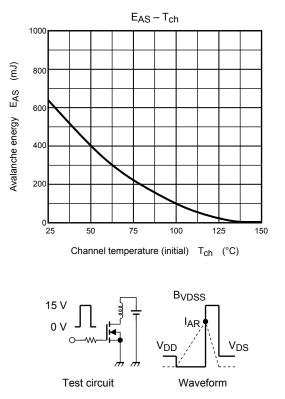








Safe operating area 500 300 ID max (pulsed) 100 . 100 μs E ID max (continuous) 50 1 ms Drain current I_D 30 1(DC operation Single nonrepetitive pulse Tc = 25°C 3 Curves must be derated linearly with increase in temperature 3 10 30 100 Drain-source voltage V_{DS} (V)



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